# P-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}\left(\Omega\right)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)			
- 60	0.0022 at V <sub>GS</sub> = - 10 V	- 50	126 nC			
	0.0026 at V <sub>GS</sub> = - 4.5 V	- 50				

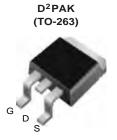
#### **FEATURES**

- DT-Trench Power MOSFET
- 100 % UIS Tested

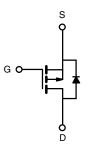
#### **APPLICATIONS**

· Load Switch









P-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)						
PARAMETER	SYMBOL	LIMIT	UNIT			
Drain-Source Voltage	$V_{DS}$	- 60	V			
Gate-Source Voltage	$V_{GS}$	± 20	V			
Continuous Drain Current d	T <sub>C</sub> = 25 °C	1	- 50	Α		
$(T_J = 175  ^{\circ}C)$	T <sub>C</sub> = 100 °C	I <sub>D</sub>	- 37			
Pulsed Drain Current	I <sub>DM</sub>	-200	] ^			
Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	-46			
Single Pulse Avalanche Energy <sup>a</sup>	L = 0.1 MH	E <sub>AS</sub>	753	mJ		
Deway Dissinction	T <sub>C</sub> = 25 °C °C	0	161	W		
Power Dissipation	T <sub>A</sub> = 25 °C b	$P_{D}$	3.37	] vv		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	UNIT		
Junction-to-Ambient	PCB mount b	$R_{thJA}$	40	°C/W		
Junction-to-Case		$R_{thJC}$	0.75	C/VV		

#### Notes

- a. Duty cycle ≤ 1 %.
- b. When mounted on 1" square PCB (FR4 material).
- c. See SOA curve for voltage derating.

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 60			V
V <sub>DS</sub> Temperature Coefficient	ΔV <sub>DS</sub> /T	I <sub>D</sub> = - 250 μA		58		mV/°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1β = 230 μΛ		- 5.2		1111/7
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1		- 3	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zara Cata Valtaga Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 60 V, V <sub>GS</sub> = 0 V			- 10	μΑ
Zero Gate Voltage Drain Current		V <sub>DS</sub> = - 60 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 25	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	V <sub>DS</sub> = - 5 V, V <sub>GS</sub> = - 10 V	- 50			Α
Durate Occurre October 5	_	V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 30 A	0.022 0.027		0.027	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 20 A		0.026 0.033		Ω
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 30 A	16			S
Dynamic <sup>b</sup>						
Input Capacitance	C <sub>iss</sub>			3376		pF
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz		1090		
Reverse Transfer Capacitance	C <sub>rss</sub>			595		
Total Gate Charge	$Q_g$			126	195	
Gate-Source Charge	$Q_{gs}$	V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 30 A		36		nC
Gate-Drain Charge	$Q_{gd}$			73		
Gate Resistance	$R_{g}$	f = 1 MHz		5.5		Ω
Turn-On Delay Time	t <sub>d(on)</sub>			35		
Rise Time	t <sub>r</sub>	$V_{DD} = -2 \text{ V}, R_L = 2 \Omega$		96		ns
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 10 A, $V_{GEN}$ = - 10 V, $R_g$ = 1 $\Omega$		50		
Fall Time	t <sub>f</sub>			82		
<b>Drain-Source Body Diode Characteristics</b>	;					
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 50	^
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				- 200	A
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 30 A		- 1	- 1.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			75	108	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	1 20 A di/dt 100 A/vo T 25 °C		149	320	nC
Reverse Recovery Fall Time	ta	$I_F = -30 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		29		
Reverse Recovery Rise Time	t <sub>b</sub>			16		ns

#### Notes:

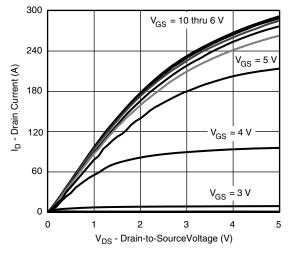
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

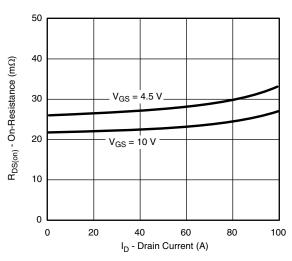




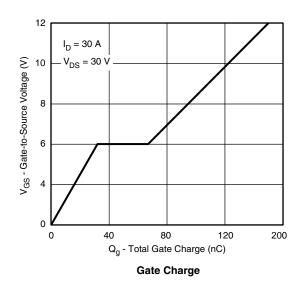
#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



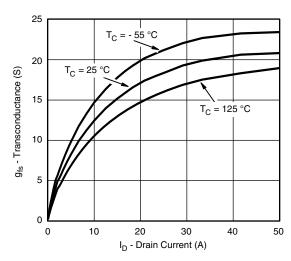
#### **Output Characteristics**



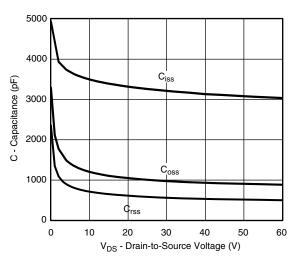
On-Resistance vs. Drain Current



**Transfer Characteristics** 



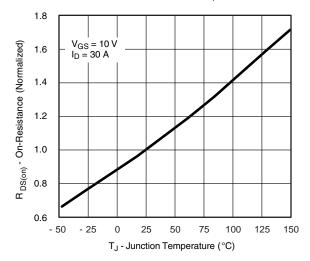
Transconductance



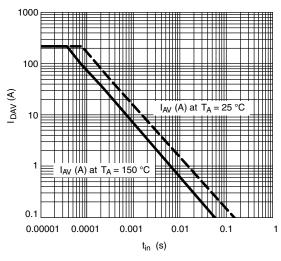
Capacitance



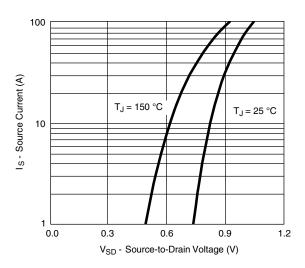
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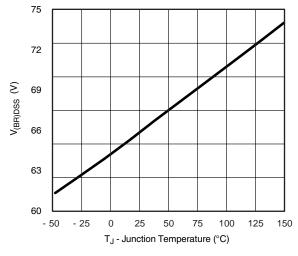
On-Resistance vs. Junction Temperature



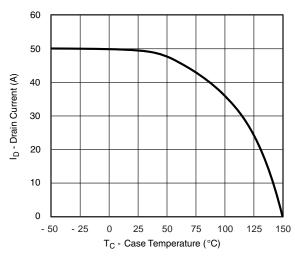
Avalanche Current vs. Time



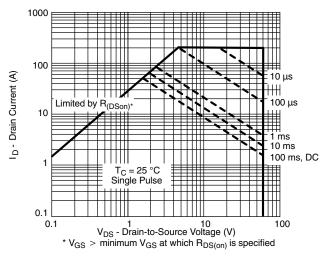
Source-Drain Diode Forward Voltage



**Drain Source Breakdown vs. Junction Temperature** 



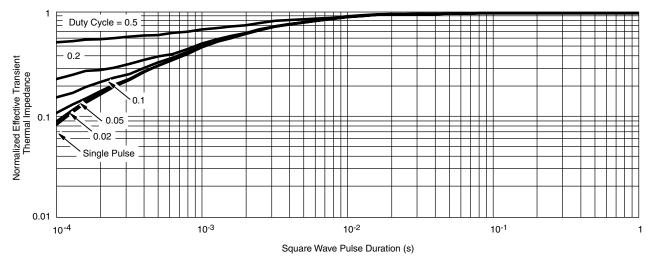
Maximum Avalanche and Drain Current vs. Case Temperature



Safe Operating Area



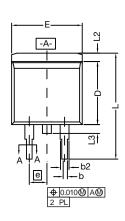
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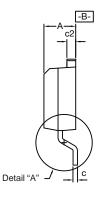


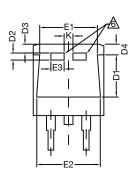
Normalized Thermal Transient Impedance, Junction-to-Case



# TO-263 (D<sup>2</sup>PAK): 3-LEAD

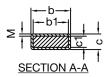








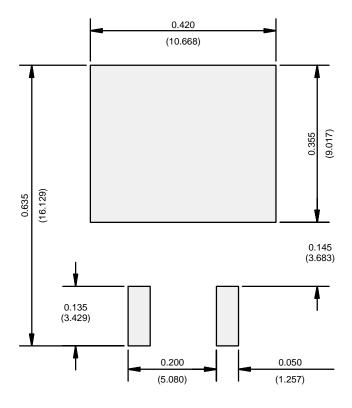
DETAIL A (ROTATED 90°)



		INC	HES	MILLIMETERS		
DIM.		MIN.	MAX.	MIN.	MAX.	
Α		0.160	0.190	4.064	4.826	
	b	0.020	0.039	0.508	0.990	
	b1	0.020	0.035	0.508	0.889	
	b2	0.045	0.055	1.143	1.397	
C*	Thin lead	0.013	0.018	0.330	0.457	
C	Thick lead	0.023	0.028	0.584	0.711	
c1	Thin lead	0.013	0.017	0.330	0.431	
CI	Thick lead	0.023	0.027	0.584	0.685	
	c2	0.045	0.055	1.143	1.397	
	D	0.340	0.380	8.636	9.652	
	D1	0.220	0.240	5.588	6.096	
	D2	0.038	0.042	0.965	1.067	
	D3	0.045	0.055	1.143	1.397	
	D4	0.044	0.052	1.118	1.321	
	E	0.380	0.410	9.652	10.414	
	E1	0.245	-	6.223	-	
	E2	0.355	0.375	9.017	9.525	
	E3	0.072	0.078	1.829	1.981	
	е	0.100	0.100 BSC		BSC	
	K	0.045	0.055	1.143	1.397	
	L	0.575	0.625	14.605	15.875	
	L1	0.090	0.110	2.286	2.794	
	L2	0.040	0.055	1.016	1.397	
	L3	0.050	0.070	1.270	1.778	
	L4	0.010	) BSC	0.254	BSC	
	М	-	0.002	-	0.050	



### RECOMMENDED MINIMUM PADS FOR D2PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)





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